Search Notes

Application/Control	No. Applicant(s)/Pateń Reexamination	t under
10/059,907	HANSON ET AL.	
Examiner	Art Unit	
Lois Zheng	1742	

SEARCHED				
Class	Subclass	Date	Examiner	
204	212	11/16/2005	LLZ	
204	224R	11/16/2005	LLZ	
204	224M	11/16/2005	LLZ	
204	242	11/16/2005	LLZ	
204	275.1	11/16/2005	LLZ	
204	282	11/16/2005	LLZ	
204	286.1	11/16/2005	LLZ	
205	80	11/16/2005	LLZ	
205	157	11/16/2005	LLZ	
		,		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
-				
-	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventorship search	11/16/2005	LLZ		
See Attached EAST Search	11/17/2005	LLZ		
·				